## Application/Control No. 10/063,087 Applicant(s)/Patent Under Reexamination LEE ET AL. Examiner Wesley A. Nicolas Applicant(s)/Patent Under Reexamination LEE ET AL. Pag 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,554,571	04-2003	Lee et al.	416/92
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## NON-PATENT DOCUMENTS

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